



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Zuk et al

Art Unit : 2131

Serial No.: 10/072,683

Examiner: Gail O. Hayes

Filed Title

: February 8, 2002

: MULTI-METHOD GATEWAY-BASED NETWORK SECURITY SYSTEMS

AND METHODS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 RECEIVED

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INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Leposit Account No. 06-1050.

Respectfully submitted,

Date:

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Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket N 09725-017001

Application No. 10/072,683

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Applicant Zuk et al

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(37 CFR §1.98(b))

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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Other Documents (include Author, Title, Date, and Place of Publication)						
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